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CONFIRMATION NO. 6313

SERIAL NUMBER 10/082,430	FILING OR 371(c) DATE 02/22/2002 RULE	CLASS 356	GROUP ART UNIT 2877	ATTORNEY DOCKET NO. 16869P-041700US
APPLICANTS Mineo Nomoto, Yokohama, JAPAN; Takenori Hirose, Machida, JAPAN; Keiya Saito, Hiratsuka, JAPAN;				
** CONTINUING DATA ***** <i>mm</i>				
** FOREIGN APPLICATIONS ***** <i>mm</i> JAPAN 2001-226984 07/27/2001				
IF REQUIRED, FOREIGN FILING LICENSE GRANTED ** 03/21/2002				
Foreign Priority claimed <input checked="" type="checkbox"/> yes <input type="checkbox"/> no 35 USC 119 (a-d) conditions <input checked="" type="checkbox"/> yes <input type="checkbox"/> no <input type="checkbox"/> Met after met Verified and Acknowledged <i>mm</i> <i>mm</i> Examiner's Signature Initials		STATE OR COUNTRY JAPAN	SHEETS DRAWING 15	TOTAL CLAIMS 8
INDEPENDENT CLAIMS 4				
ADDRESS 20350				
TITLE Method and apparatus for measuring thickness of thin film and device manufacturing method using same				
FILING FEE RECEIVED 954	FEES: Authority has been given in Paper No. _____ to charge/credit DEPOSIT ACCOUNT No. _____ for following:		<input type="checkbox"/> All Fees <input type="checkbox"/> 1.16 Fees (Filing) <input type="checkbox"/> 1.17 Fees (Processing Ext. of time) <input type="checkbox"/> 1.18 Fees (Issue) <input type="checkbox"/> Other _____ <input type="checkbox"/> Credit	